STATEMENT BY APPLICANT	APPLICANT:	Richard R. Bijjani, e	et al
Sheet 1 of 2	GROUP ART UNIT:	2882	EXAMINER: Not yet assigned

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^{. *}a copy of this reference is not provided as it was previously cited by or submitted to the office in a prior application, Serial No. 10/068.459, filed February 6, 2002, and relied upon for an earlier filing date under 35 U.S.C. 120 (continuation, continuation-in-part, and divisional applications).